

N-channel 80 V 8.7 mΩ standard level MOSFET in D2PAKRev. 1 — 24 October 2011Objective data

**Objective data sheet** 

#### **Product profile** 1.

### **1.1 General description**

Standard level N-channel MOSFET in D2PAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

#### 1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive

#### **1.3 Applications**

- DC-to-DC converters
- Load switching

- Motor control
- Server power supplies

#### 1.4 Quick reference data

Table 1.	Quick reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	-	80	V
I <sub>D</sub>	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u>	-	-	90	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	-	170	W
Tj	junction temperature		-55	-	175	°C
Static cha	aracteristics					
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 100 °C; see <u>Figure 12</u>	-	-	14	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 10 A; $T_j$ = 25 °C; see <u>Figure 13</u>	-	7.5	8.7	mΩ
Dynamic	characteristics					
$Q_{GD}$	gate-drain charge	$V_{GS}$ = 10 V; $I_{D}$ = 25 A; $V_{DS}$ = 40 V;	-	11	-	nC
Q <sub>G(tot)</sub>	total gate charge	see Figure 14; see Figure 15	-	52	-	nC
Avalanch	e ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$      V_{GS} = 10 \text{ V};  \text{T}_{j(init)} = 25 \text{ °C};  \text{I}_{\text{D}} = 90 \text{ A}; \\       V_{sup} \leq 80 \text{ V};  \text{R}_{\text{GS}} = 50  \Omega; \text{ unclamped} $	-	-	120	mJ
						-



N-channel 80 V 8.7 mΩ standard level MOSFET in D2PAK

### 2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain <sup>[1]</sup>	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S

SOT404 (D2PAK)

[1] It is not possible to make connection to pin 2

### 3. Ordering information

#### Table 3.Ordering information

Type number	Package		
	Name	Description	Version
PSMN8R7-80BS	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

## 4. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	80	V
V <sub>DGR</sub>	drain-gate voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C; R <sub>GS</sub> = 20 kΩ	-	80	V
V <sub>GS</sub>	gate-source voltage		-20	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; see <u>Figure 1</u>	-	64	А
		$V_{GS}$ = 10 V; $T_{mb}$ = 25 °C; see <u>Figure 1</u>	-	90	А
I <sub>DM</sub>	peak drain current	pulsed; t <sub>p</sub> ≤ 10 µs; T <sub>mb</sub> = 25 °C; see <u>Figure 3</u>	-	361	A
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	170	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
T <sub>sld(M)</sub>	peak soldering temperature		-	260	°C
Source-drain	diode				
I <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C	-	90	А
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$	-	361	А
Avalanche rug	ggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 90 A; $V_{sup}$ ≤ 80 V; $R_{GS}$ = 50 Ω; unclamped	-	120	mJ

## PSMN8R7-80BS

#### N-channel 80 V 8.7 m $\Omega$ standard level MOSFET in D2PAK

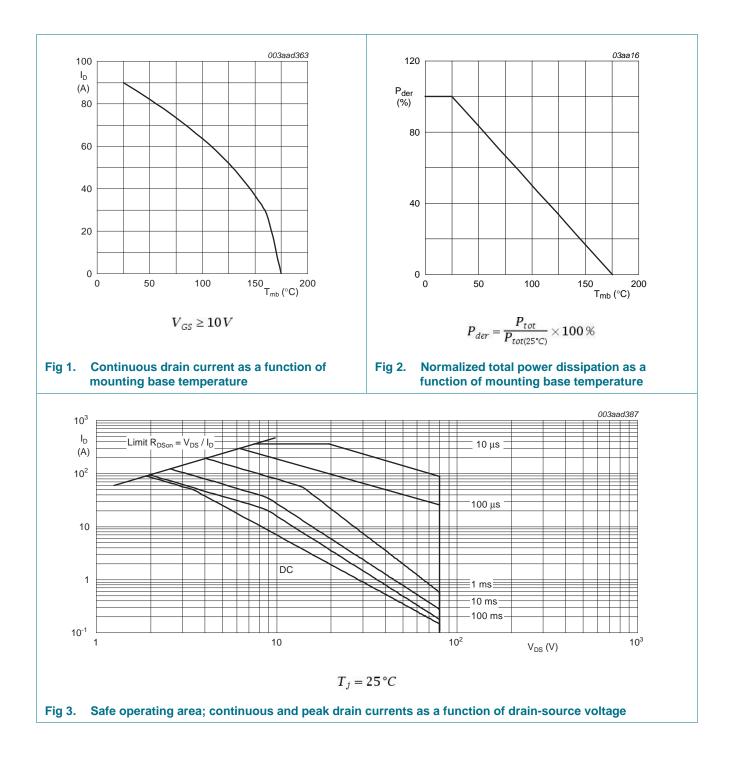


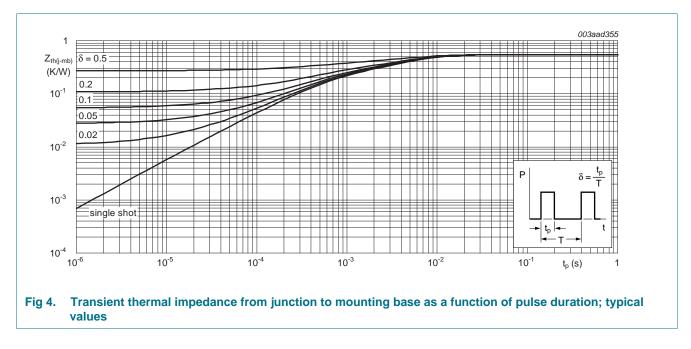
Table C

N-channel 80 V 8.7 mΩ standard level MOSFET in D2PAK

### 5. Thermal characteristics

Thermal characteristics

Table 5.	I nermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	see Figure 4	-	0.54	0.88	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	Minimum footprint; mounted on a printed circuit board	-	50	-	K/W



N-channel 80 V 8.7 m $\Omega$  standard level MOSFET in D2PAK

### 6. Characteristics

#### Table 6. Characteristics

Tested to JEDEC standards where applicable.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics					
V <sub>(BR)DSS</sub>	drain-source breakdown	$I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^\circ\text{C}$	73	-	-	V
	voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ C$	80	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 175 °C; see <u>Figure 10</u>	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see Figure 10	-	-	4.6	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 11; see Figure 10	2.3	3	4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.3	5	μA
		$V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$	-	-	100	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = -20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	10	100	nA
		$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 175 °C; see <u>Figure 12</u>	-	-	20.88	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 10 A; $T_j$ = 100 °C; see <u>Figure 12</u>	-	-	14	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 10 A; $T_j$ = 25 °C; see <u>Figure 13</u>	-	7.5	8.7	mΩ
R <sub>G</sub>	internal gate resistance (AC)	f = 1 MHz	-	1	-	Ω
Dynamic ch	aracteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 0 \text{ A}; \text{ V}_{DS} = 0 \text{ V}; \text{ V}_{GS} = 10 \text{ V}$	-	44	-	nC
		$I_D = 25 \text{ A}; V_{DS} = 40 \text{ V}; V_{GS} = 10 \text{ V};$	-	52	-	nC
Q <sub>GS</sub>	gate-source charge	see <u>Figure 14;</u> see <u>Figure 15</u>	-	15	-	nC
Q <sub>GS(th)</sub>	pre-threshold gate-source charge	$I_D = 25 \text{ A}; \text{ V}_{DS} = 40 \text{ V}; \text{ V}_{GS} = 10 \text{ V};$ see Figure 14	-	9.2	-	nC
Q <sub>GS(th-pl)</sub>	post-threshold gate-source charge		-	5.8	-	nC
Q <sub>GD</sub>	gate-drain charge	$I_D = 25 \text{ A}; V_{DS} = 40 \text{ V}; V_{GS} = 10 \text{ V};$ see Figure 14; see Figure 15	-	11	-	nC
V <sub>GS(pl)</sub>	gate-source plateau voltage	$I_D = 25 \text{ A}; V_{DS} = 40 \text{ V}; \text{ see } \frac{\text{Figure } 15}{100000000000000000000000000000000000$	-	4.6	-	V
C <sub>iss</sub>	input capacitance	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; \text{ f} = 1 \text{ MHz};$	-	3346	-	pF
C <sub>oss</sub>	output capacitance	$T_j = 25 \text{ °C}; \text{ see } Figure 16$	-	296	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	158	-	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 40 \text{ V}; \text{ R}_{L} = 1.6 \Omega; V_{GS} = 10 \text{ V}; \label{eq:VDS}$	-	21	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 4.7 \ \Omega$	-	26	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	46	-	ns
t <sub>f</sub>	fall time		-	20	-	ns

Symbol

V<sub>SD</sub>

Source-drain diode

## PSMN8R7-80BS

Тур

0.79

42

66

Max

1.2

-

-

Unit

V

ns

nC

#### N-channel 80 V 8.7 mΩ standard level MOSFET in D2PAK

Min

-

-

#### $I_{S} = 25 \text{ A}; \text{ d}I_{S}/\text{d}t = 100 \text{ A}/\mu\text{s};$ reverse recovery time t<sub>rr</sub> $V_{GS} = 0 V; V_{DS} = 40 V$ recovered charge Qr 003aad449 100 100 20 5.5 $\mathsf{I}_\mathsf{D}$ $I_D$ (A) 5 (A) 8 80 80 60 60 40 40 4.5 20 20 $I_{GS}(V) = 4$ 0 0 0 1 2 <sup>3</sup> V<sub>DS</sub> (V) <sup>4</sup> 0 2 $T_i = 25 \,^{\circ}C$ Output characteristics: drain current as a Fig 5. Fig 6. function of drain-source voltage; typical values 003aad455 5000 100 С g<sub>fs</sub> Ciss (pF) (S) 4000 80 Crss 3000 60 2000 40 1000 20 0 0 0 3 6 9 <sub>VGS (V)</sub> 12 20 0 $V_{DS} = 0V; f = 1MHz$ Fig 7. Input and reverse transfer capacitances as a Fig 8. function of gate-source voltage; typical values

Conditions

see Figure 17

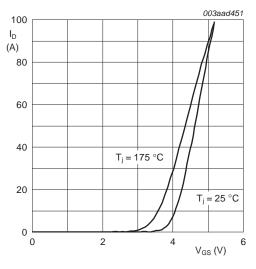
 $I_{S} = 10 \text{ A}; V_{GS} = 0 \text{ V}; T_{i} = 25 \text{ °C};$ 

#### Table 6. Characteristics ...continued

Tested to JEDEC standards where applicable.

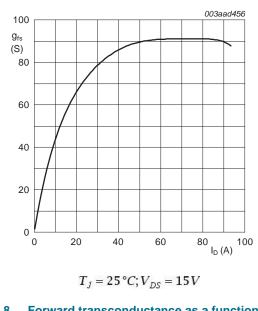
source-drain voltage

Parameter







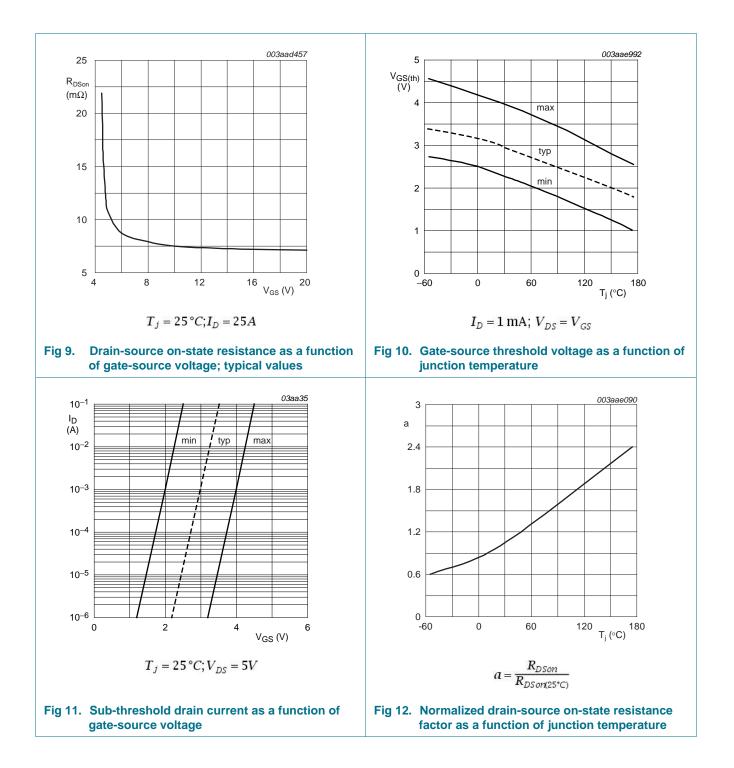




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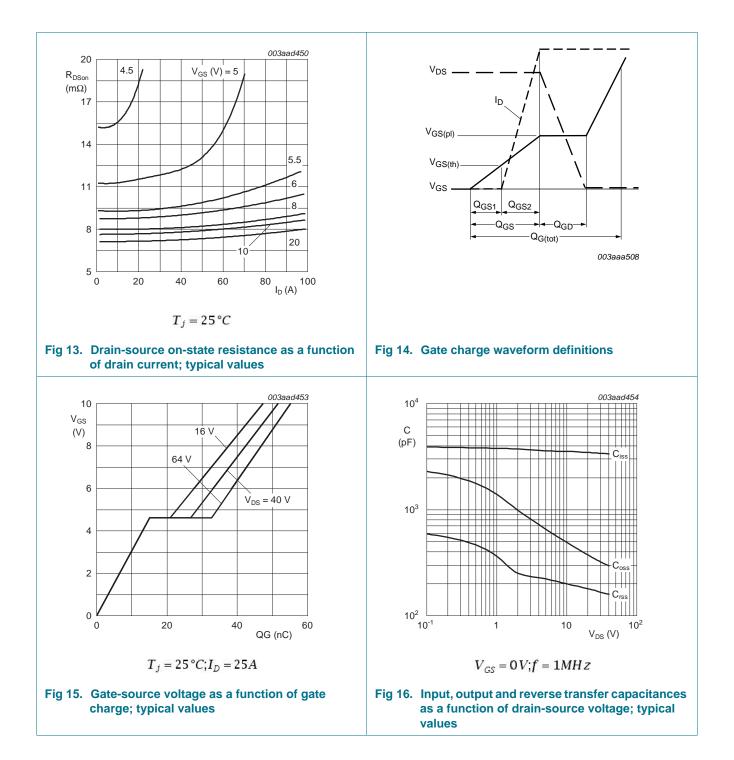
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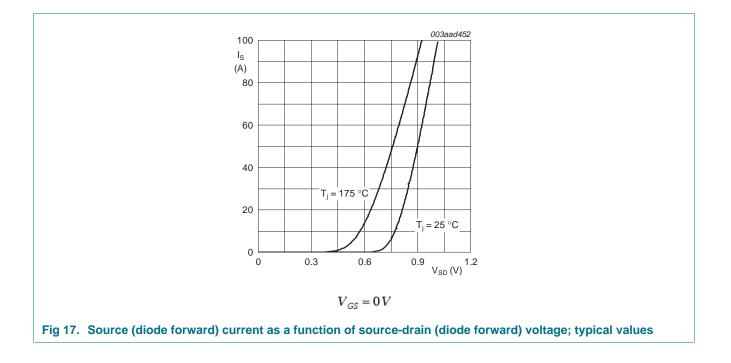
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#### N-channel 80 V 8.7 mΩ standard level MOSFET in D2PAK



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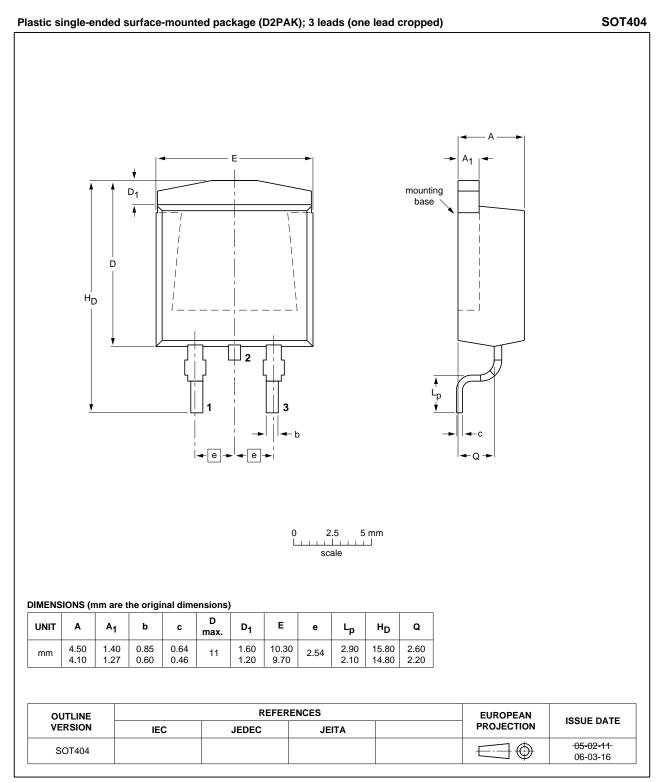
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## PSMN8R7-80BS

#### N-channel 80 V 8.7 mΩ standard level MOSFET in D2PAK

### 7. Package outline



#### Fig 18. Package outline SOT404 (D2PAK)

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#### N-channel 80 V 8.7 m $\Omega$ standard level MOSFET in D2PAK

## 8. Revision history

Table 7. Revision h	Revision history						
Document ID	Release date	Data sheet status	Change notice	Supersedes			
PSMN8R7-80BS v.1	20111024	Objective data sheet	-	-			

### 9. Legal information

#### 9.1 Data sheet status

Document status [1] [2]	Product status 3	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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